Form PTO-1449 Sheet 1 of 2 Applicant: Takashi Saida et al. Confirmation No.: 5371 Serial No.: 10/587,446 Att'y Docket No.: 14321.89 Filing Date: July 25, 2006 Art Unit: 2874 For: PLANAR LIGHTWAVE CIRCUIT, DESIGN METHOD FOR WAVE PROPAGATION CIRCUIT, AND COMPUTER PROGRAM INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANT U.S. Patent Documents Examiner Document Issue Initial* Number Date Name Foreign Patent Documents Examiner Document Publication Country or Initial* Number Patent Office Translation Date 01/26/1987 Partial 1 62-017708 Japan 2 02-126205 05/15/1990 Japan Partial 1 3 05-060929 03/12/1993 No Japan __ 4 09-297228 11/18/1997 No Japan 5 10-090537 04/10/1998 Japan **Partial** 6 11-133253 05/21/1999 Partial Japan 7 2002-90561 03/27/2002 Japan No Other Documents (including author, title, pertinent pages, etc.) Examiner Initial* Z. Weissman et al., Analysis of Periodically Segmented Waveguide Mode Expanders, Journal of 8 Lightwave Technology, Vol. 13, No. 10, October 1995, pp. 2053-2058. 9 Michael M. Spuhler et al., A Very Short Planar Silica Spot-Size Converter Using a Nonperiodic

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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609, draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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10	Katsunari Okamoto, Fundamentals of Optical W	Yaveguides, Academic Press, 2000, pp. 294-303.
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	References Cited by A	pplicants
Section 609 of Information Dis other item of in readily available	the Manual of Patent Examining Procedure and 37 of sclosure Statement, Form PTO-1449 shall be accompanion and a translation of the pertinent portion	antary, the procedure is governed by the guidelines of C.F.R. §§ 1.97 and 1.98. To be considered a proper anied by a copy of each listed patent or publication or s of foreign documents (if an existing translation is ch reference not in the English language, and should
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